Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/032,185	IZUMIYA ET AL.	
Examiner	Art Unit	
Hai C. Pham	2861	

SEARCHED					
Class	Subclass	Date	Examiner		
347	234-237, 240, 246- 254	2/28/2006	НР		
375	226	2/28/2006	HP		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
347	249	2/28/2006	НР		
PGPub Text Search		2/28/2006	НР		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Text Search	2/28/2006	HP		